

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/692,110	NAGAR ET AL.	
Examiner	Art Unit	

2829

Emily Y. Chan

SEARCHED					
Subclass	Date	Examiner			
754	2-2-05	EC			
750-765	2/2/2005	EC			
	Subclass 754	Subclass Date 754 2-2-05			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Inventorship and EAST for all databass searched	2/2/2005	EC			
Consultrd with primary examiner Mr. Vinh P. Nguyen	2-2-05	EC			